

## Dual N-Ch 20V MOSFETs

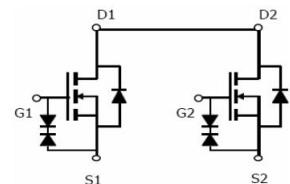
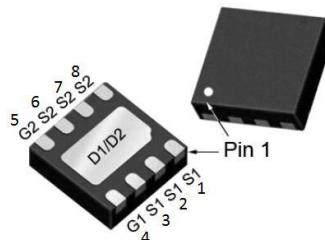
- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

## Product Summary



BVDSS	RDS(on)	ID
20V	4.4mΩ	50A

## DFN3030-8L Pin Configurations



## FEATURE

- TrenchFET Power MOSFET
- Excellent R<sub>DS(on)</sub>
- Low Gate Charge
- High Power and Current Handling Capability
- Surface Mount Package
- ESD Rating: 2000V HBM

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	50	A
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	31	A
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	100	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	135	mJ
I <sub>AS</sub>	Avalanche Current	52	A
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	---	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>	---	38	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>	---	---	°C/W

## Dual N-Ch 20V MOSFETs

Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	20	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$\text{BV}_{\text{DSS}}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$	---	---	---	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{\text{GS}}=4.5\text{V}$ , $I_D=8\text{A}$	---	4.4	5.2	$\text{m}\Omega$
		$V_{\text{GS}}=2.5\text{V}$ , $I_D=6\text{A}$	---	5.3	6	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D=250\mu\text{A}$	0.5	0.6	1	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		---	---	---	$\text{mV}/^\circ\text{C}$
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	1	$\text{uA}$
		$V_{\text{DS}}=20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=100^\circ\text{C}$	---	---	100	
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}= \pm 12\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm 7$	$\text{uA}$
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=5\text{V}$ , $I_D=4\text{A}$	---	10	---	S
$R_g$	Gate Resistance	$V_{\text{DS}}=0\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	---	---	$\Omega$
$Q_g$	Total Gate Charge	$V_{\text{DS}}=10\text{V}$ , $V_{\text{GS}}=4.5\text{V}$ , $I_D=6\text{A}$	---	36	---	$\text{nC}$
$Q_{\text{gs}}$	Gate-Source Charge		---	3.2	---	
$Q_{\text{gd}}$	Gate-Drain Charge		---	13	---	
$T_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=10\text{V}$ , $I_D=6\text{A}$ , $R_G = 3\Omega$ , $V_{\text{GS}}=4.5\text{V}$	---	8.2	---	$\text{ns}$
$T_r$	Rise Time		---	35	---	
$T_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	372	---	
$T_f$	Fall Time		---	213	---	
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=10\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{KHz}$	---	2610	---	$\text{pF}$
$C_{\text{oss}}$	Output Capacitance		---	345	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	322	---	

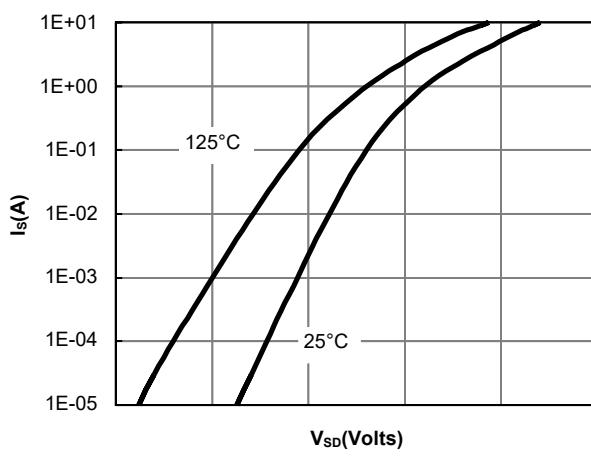
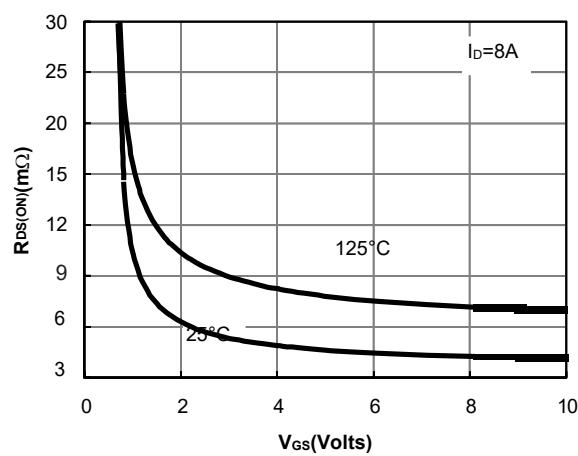
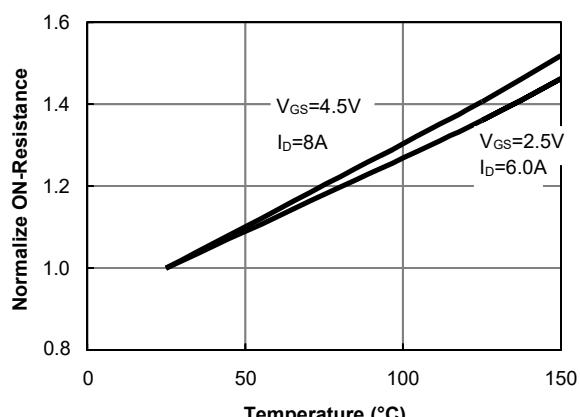
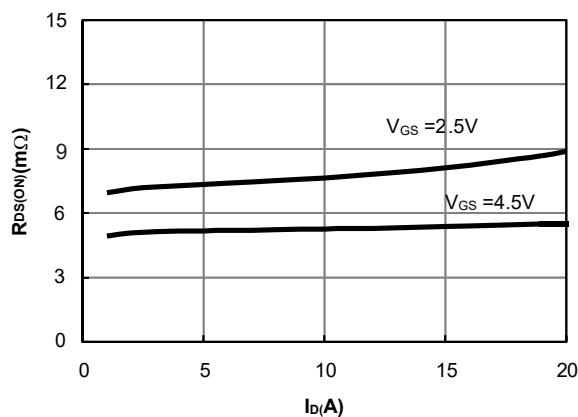
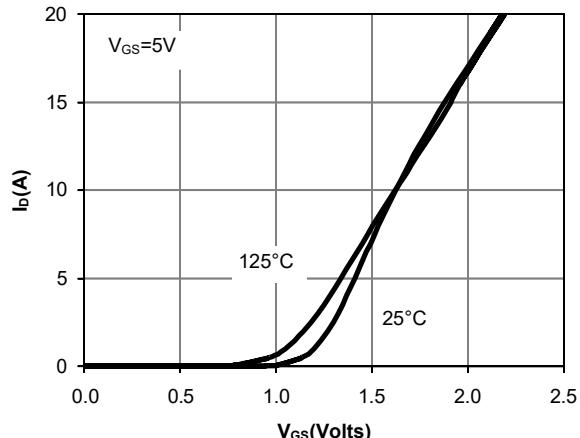
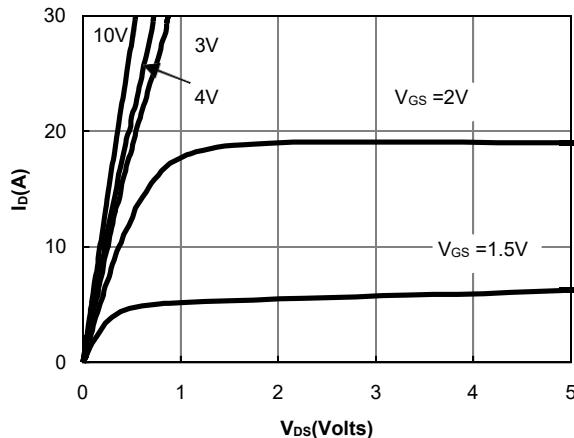
## Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current <sup>1,4</sup>	$V_G=V_D=0\text{V}$ , Force Current	---	---	50	A
$V_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$V_{\text{GS}}=0\text{V}$ , $I_s=1.5\text{A}$ , $T_J=25^\circ\text{C}$	---	---	1	V
$t_{\text{rr}}$	Reverse Recovery Time	$IF=5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$	---	---	---	nS
			---	---	---	nC

## Notes :

- 1.Repetitive rating: Pulse width limited by maximum junction temperature
- 2.Surface Mounted on FR4 board,  $t \leq 10$  sec.
- 3.. EAS condition : $T_J=25^\circ\text{C}$ ,  $V_{\text{DD}}=40\text{V}$ ,  $V_{\text{G}}=10\text{V}$ ,  $L=0.1\text{mH}$ ,  $R_g=25\Omega$ ,  $I_{\text{AS}}=52\text{A}$
- 4.Pulse test : Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- 5.Guaranteed by design, not subject to production.

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTIC



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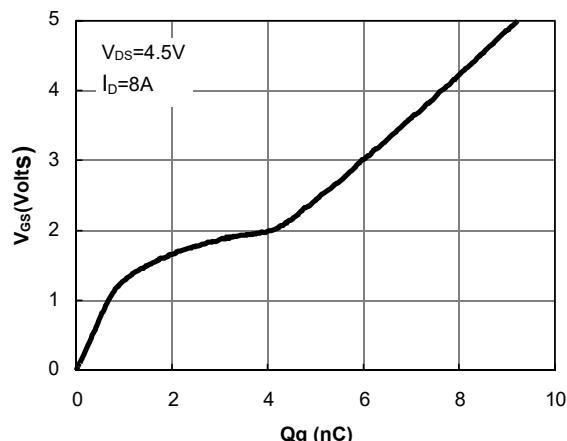


Figure 7: Gate-Charge Characteristics

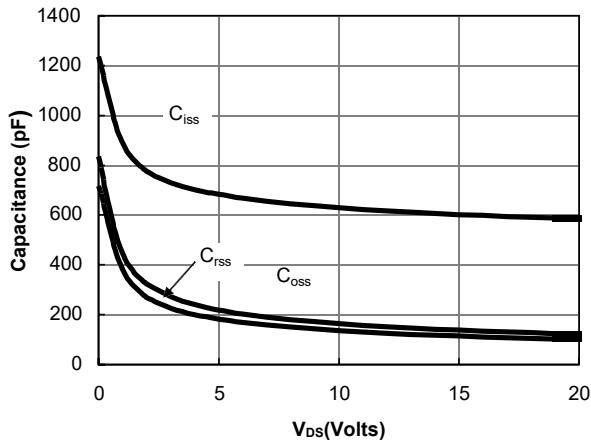


Figure 8: Capacitance Characteristics

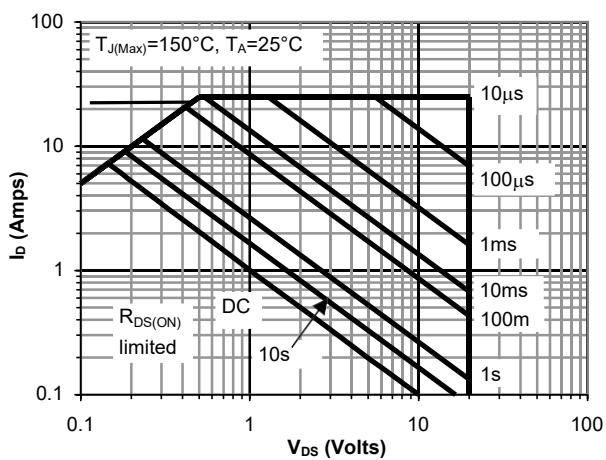


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

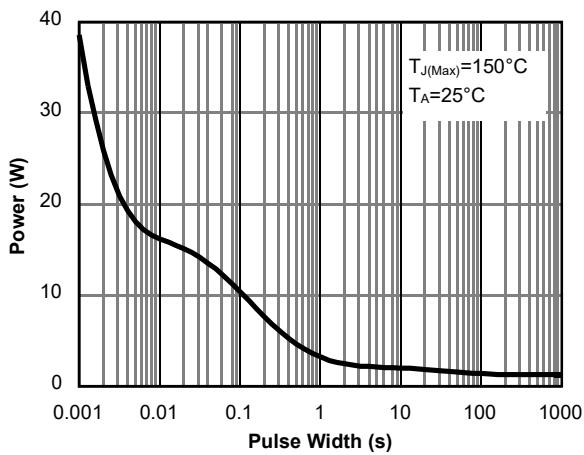


Figure 10: Single Pulse Power Rating Junction-to-Area

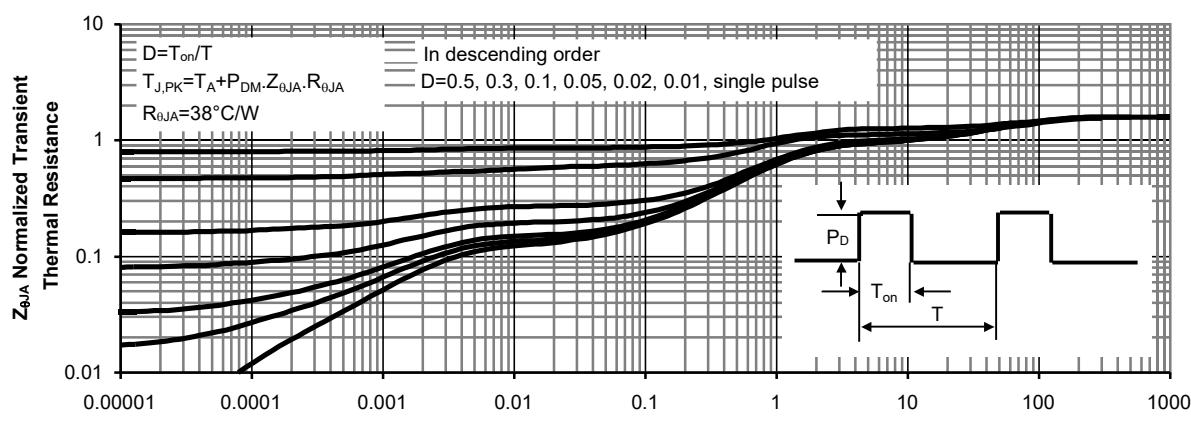
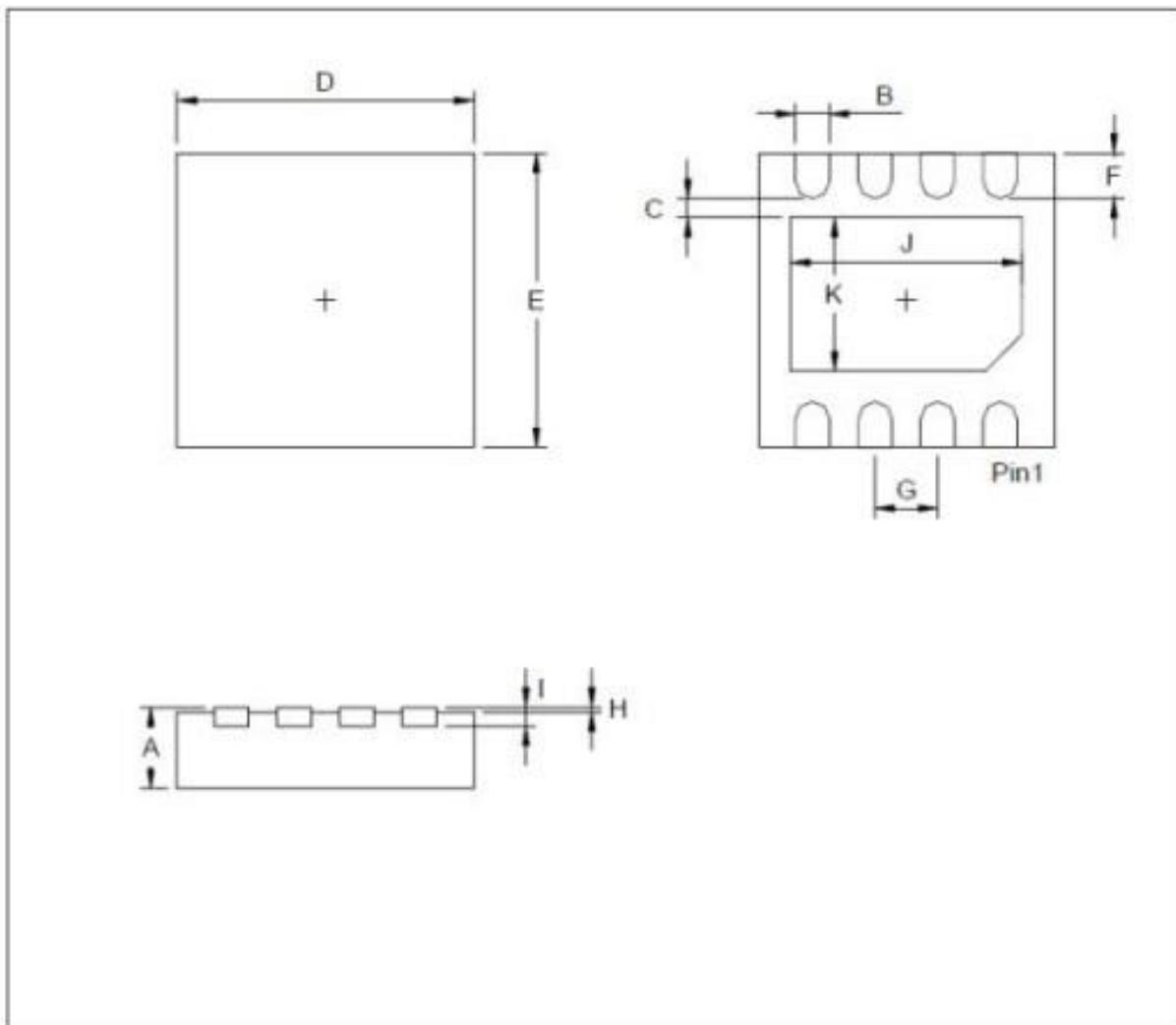


Figure 11: Normalized Maximum Transient Thermal Impedance

## DFN3030-8L Package Outline Data



Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.7		0.8	I		0.203	
B	0.25		0.35	J	2.2		2.4
C	0.2			K	1.4		1.6
D	2.924		3.076				
E	2.924		3.076				
F	0.324		0.476				
G		0.65					
H	0		0.05				